Notice of References Cited Application/Control No. 10/536,853 Examiner BRITTANY M. MARTINEZ Applicant(s)/Patent Under Reexamination AZNAR, PASCAL Page 1 of 2

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,128,114	07-1992	Schwartz, Jo-Ann T.	423/335
*	В	US-2002/0043462 A1	04-2002	Ivory et al.	204/450
*	C	US-6,360,589 B1	03-2002	Kanda et al.	73/61.52
*	D	US-2003/0220330 A1	11-2003	Yoshitaka et al.	514/227.8
*	Е	US-5,587,082	12-1996	Teraoka et al.	210/635
*	F	US-4,341,634	07-1982	Matsushita et al.	210/656
*	G	US-2002/0058286 A1	05-2002	Danishefsky et al.	435/7.1
*	Ι	US-2002/0128490 A1	09-2002	Johnston et al.	548/483
*	I	US-7,109,377	09-2006	Schreiber et al.	564/191
*	J	US-4,743,377	05-1988	Ohtsu et al.	210/635
*	K	US-4,830,921	05-1989	Kitayama et al.	428/406
*	L	US-5,051,176	09-1991	Miyano et al.	210/198.2
*	М	US-5,135,649	08-1992	Kanda et al.	210/198.2

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Ø					
	R					
	Ø					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	U	Kazue Tani et al., "Effect of pore size on the surface exces isotherm of silica packings," 1990, Journal of Chromatography, 515, pp. 159-168.				
	V	Kamegawa et al., "Carbon Coating of Silica Surface," 1995, Journal of Colloid and Interface Science, 172, pp. 94-97.				
	w	Sigma Aldrich, "Silica gel," 12/15/2009.				
	x					

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Notice of References Cited Application/Control No. 10/536,853 Applicant(s)/Patent Under Reexamination AZNAR, PASCAL Examiner BRITTANY M. MARTINEZ Art Unit Page 2 of 2

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,074,555	06-2000	Boos et al.	210/198.2
*	В	US-2002/0058817 A1	05-2002	Danishefsky et al.	546/281.7
	O	US-			
	D	US-			
	ш	US-			
	F	US-			
	G	US-			
	Н	US-			
	-	US-			
	٦	US-			
	K	US-			
	L	US-			
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FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.